

Search Notes

Application/Control No.

10/031,146

Examiner

YONG D. PAK

Applicant(s)/Patent under
Reexamination

HAUER ET AL.

Art Unit

1652

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
435	189	1/25/2011	YP
435	440	1/25/2011	YP
435	132	1/25/2011	YP
stic: seq id no:2		1/25/2011	YP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east (all databases): text & inventor search, see search history	1/25/2011	YP
stic: seq id no:2, see SCORE	1/25/2011	YP
PALM: inventor search	1/25/2011	YP